

Notice of References Cited

Application/Control No.

10/031,618

Applicant(s)/Patent Under
Reexamination
YOSHIMARU ET AL.

Examiner

Tae H Yoon

Art Unit

1714

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3,211,679	10-1965	UPDEGRAFF DAVID M	106/18.3
	B	US-4,174,339	11-1979	Matsuda et al.	523/177
	C	US-6,462,102	10-2002	Yamamori et al.	523/122
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 98/33829	08-1998	WIPO	Abstract only	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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